

Search Notes (continued)

Application/Control No.

10/625,554

Examiner

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Applicant(s)/Patent under
Reexamination

ITO ET AL.

Art Unit

2825

SEARCHED

Class	Subclass	Date	Examiner
716	11	8/15/2006	JSL
716	8	8/15/2006	JSL
716	9	8/15/2006	JSL
716	10	8/15/2006	JSL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST [USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB]	8/15/2006	JSL